DELIVERY SPECIFICATION

SPEC. No. C-Soft-h

D A T E : Sep., 2022

To

Non-Controlled Copy

CUSTOMER'S PRODUCT NAME

TDK PRODUCT NAME

MULTILAYER CERAMIC CHIP CAPACITORS(Soft Termination)
Bulk and Tape packaging [RoHS2 compliant]
C1005,C1608,C2012,C3216,C3225,C4532,C5750,C7563 Type
C0G,X5R,X7R,X7S,X7T,X8R,X8L Characteristics

Please return this specification to TDK representatives with your signature. If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

RECEIPT CONFIRMATION

DATE: YEAR MONTH DAY

TDK Corporation Sales Electronic Components Sales & Marketing Group

Engineering
Electronic Components Business Company

Ceramic Capacitors Business Group

APPROVED	Person in charge

APPROVED	CHECKED	Person in charge

SCOPE

This delivery spe	cification shall	be applied to	Multilayer	ceramic chi	capacitors(Soft	Termination	Electrode)
to be delivered to)						

PRODUCTION PLACES

Production places defined in this specification shall be TDK Corporation, TDK(Suzhou)Co.,Ltd and TDK Components U.S.A.,Inc.

PRODUCT NAME

The name of the product to be defined in this specifications shall be $C \diamondsuit \diamondsuit \diamondsuit O O \lozenge \triangle \Box \Box \Box \times @ \times \times S$.

REFERENCE STANDARD

JIS C 5101-1:2010	Fixed capacitors for use in electronic equipment-Part 1: Generic specification
C 5101-21:2014	Fixed capacitors for use in electronic equipment-Part 21 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class1
C 5101-22:2014	Fixed capacitors for use in electronic equipment-Part 22 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class2
C 0806-3:2014	Packaging of components for automatic handling - Part 3: Packaging of
	surface mount components on continuous tapes
JEITA RCR-2335 C 2014	Safety application guide for fixed ceramic capacitors for use in electronic
	equipment

CONTENTS

- 1. CODE CONSTRUCTION
- 2. COMBINATION OF RATED CAPACITANCE AND TOLERANCE
- 3. OPERATING TEMPERATURE RANGE
- 4. STORING CONDITION AND TERM
- 5. P.C. BOARD
- 6. INDUSTRIAL WASTE DISPOSAL
- 7. PERFORMANCE
- 8. INSIDE STRUCTURE AND MATERIAL
- 9. CAUTION FOR PRODUCTS WITH SOFT TERMINATION
- 10. PACKAGING
- 11. RECOMMENDATION
- 12. SOLDERING CONDITION
- 13. CAUTION
- 14. TAPE PACKAGING SPECIFICATION

<EXPLANATORY NOTE>

When the mistrust in the spec arises, this specification is given priority. And it will be confirmed by written spec change after conference of both posts involved.

This specification warrants the quality of the ceramic chip capacitor. Capacitors should be evaluated or confirmed a state of mounted on your product.

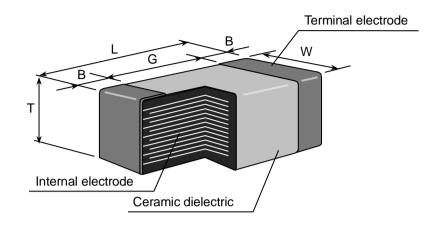
If the use of the capacitors goes beyond the bounds of this specification, we can not afford to guarantee.

Division	Date	SPEC. No.
Ceramic Capacitors Business Group	September, 2022	C-Soft-h

1. CODE CONSTRUCTION

(Example) <u>C2012</u> <u>X7R</u> <u>1H</u> <u>105</u> <u>K</u> <u>T</u> <u>****S</u> (1) (2) (3) (4) (5) (6) (7)

(1) Case size



Туре	Dimensions (Unit: mm)				
TDK[EIA style]	L	W	Т	В	G
C1005	1.00 ^{+0.15} - 0.05	0.50 ^{+0.10} - 0.05	0.50 ^{+0.10} _{-0.05}	0.10 min.	0.30 min.
[CC0402]	1.00 ^{+0.25} - 0.10	0.50 ^{+0.20} _{-0.10}	0.50 ^{+0.20} _{-0.10}	0.1011111.	0.30 11111.
C1608 [CC0603]	1.60 ^{+0.20} _{-0.10}	0.80 ^{+0.15} - 0.10	0.80 ^{+0.15} - 0.10	0.20 min.	0.30 min.
C2012	2.00+0.45	4 25 +0.25	0.60±0.15 0.85±0.15	0.20 min.	0.50 min.
[CC0805]	2.00 ^{+0.45} - 0.20	1.25 ^{+0.25} - 0.20	1.25 ^{+0.25} - 0.20	0.20 mm.	0.50 min.
			0.85±0.15		
C3216	±0.40	±0.30	1.15±0.15		1.00 min.
[CC1206]	3.20 ^{+0.40} - 0.20	1.60 ^{+0.30} - 0.20	1.30±0.20	0.20 min.	
			1.60 ^{+0.30} _{-0.20}		
	3.20 ^{+0.50} _{- 0.40}	2.50±0.30	1.60 ^{+0.30} _{-0.20}	0.20 min.	
C3225 [CC1210]			2.00 ^{+0.30} _{-0.20}		
			2.30 ^{+0.30} _{-0.20}		
			2.50±0.30		
			2.00 ^{+0.30} _{-0.20}		
C4532 [CC1812]	C4532 [CC1812] 4.50 +0.50 - 0.40	3.20±0.40	2.30 ^{+0.30} _{-0.20}	0.20 min.	
			2.50±0.30		
C5750	5.70 ^{+0.50} - 0.40	5.00±0.40	2.30 ^{+0.30} _{-0.20}	0.20 min.	
[CC2220]	- 0.40	3.0020.10	2.50±0.30		
C7563	7.50±0.50	6.30±0.50	2.50 max.	0.30 min.	
[CC3025]	7.50±0.50	0.50±0.50	3.00 max.	0.30 111111.	

^{*}As for each item, please refer to detail page on TDK web.

(2) Temperature Characteristics

* Details are shown in table 1 No.6 and No.7 at 7.PERFORMANCE

(3) Rated Voltage

Symbol	Rated Voltage
2 J	DC 630 V
2 W	DC 450 V
2 E	DC 250 V
2 A	DC 100 V
1 H	DC 50 V

Symbol	Rated Voltage
1 V	DC 35 V
1 E	DC 25 V
1 C	DC 16 V
1 A	DC 10 V
0 J	DC 6.3 V

(4) Rated Capacitance

Stated in three digits and in units of pico farads (pF). The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

(Example)	
Symbol	Rated Capacitance
105	1,000,000 pF

(5) Capacitance tolerance

* M tolerance shall be standard for over 10uF.

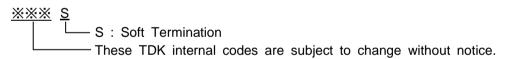
Symbol	Tolerance	
J	± 5%	
K	± 10 %	
*M	± 20 %	

(6) Packaging

* C1005 type is applicable to tape packaging only.

Symbol	Packaging
В	Bulk
Т	Taping

(7) TDK internal code



2. COMBINATION OF RATED CAPACITANCE AND TOLERANCE

Class	Temperature Characteristics	Capacitance tolerance	Rated capacitance
1	COG	J (± 5%)	E – 12 series
2	X5R X7R X7S X7T X8R X8L	K (± 10 %) M (± 20 %)	E – 6 series

Capacitance Step in E series

E series		Capacitance Step										
E- 6	1.	.0	1	.5	2	.2	3	.3	4	.7	6	.8
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2

3. OPERATING TEMPERATURE RANGE

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature
X5R	-55°C	85°C	25°C
C0G/X7R/X7S/X7T	-55°C	125°C	25°C
X8R/X8L	-55°C	150°C	25°C

4. STORING CONDITION AND TERM

Storing temperature	Storing humidity	Storing term
5~40°C	20~70%RH	Within 6 months upon receipt.

5. P.C. BOARD

When mounting on an aluminum substrate, the capacitors are more likely to be affected by heat stress from the substrate.

Please inquire separate specification when mounted on the substrate.

6. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.

7. PERFORMANCE

table 1

	T		1				
No.	Item	Performance		Test or	rinspection	n m	ethod
1	External Appearance	No defects which may affect performance.	Inspect with magnifying glass (3x)				(3x)
2	Insulation Resistance	10,000MΩ or 500MΩ·μF min. (As for the capacitors of rated voltage 16V DC and lower, 10,000MΩ or 100MΩ·μF min.), whichever smaller.	(As for 630V [the cap	age: Rate pacitor of oly 500V tion time:	rate DC.	ed voltage)
3	Voltage Proof	Withstand test voltage without insulation breakdown or other damage.		volta RV = 100V < I 500' RV = 100V < I 500' applicat	ated ge(RV) ≤100V RV≤500V V <rv :="" currel<="" rge="" rv≤500v="" td="" time="" tion="" v<rv="" ≤100v=""><td>3 x 1.5 1.3 2.5 1.5 1.3</td><td>pply voltage x rated voltage 60mA or lower</td></rv>	3 x 1.5 1.3 2.5 1.5 1.3	pply voltage x rated voltage 60mA or lower
4	Capacitance	Within the specified tolerance.	1000 ur Over (Class2 Capac 10uF according to the content of the	citance pF and nder 1000pF citance nd under 10uF ne capace	Measurir frequence 1MHz±10 1kHz±10 Measurir frequence 1kHz±10 120Hz±20 citors of rams is appl	29 29 29 29 29 29 29 29 29 29 29 29 29 2	Measuring voltage 0.5 - 5 Vrms. Measuring voltage 1.0±0.2Vrms 0.5±0.2Vrms. voltage
5	Q (Class1) Dissipation Factor (Class2)	Please refer to detail page on TDK web.		4 in this	table for		suring
6	Temperature Characteristics of Capacitance (Class1)	T.C. Temperature Coefficient COG 0 ± 30 (ppm/°C) Capacitance drift within ± 0.2% or ± 0.05pF, whichever larger.	based o tempera	n values iture. ng temp	s at 25°C perature b	and	be calculated 85°C / 25°C shall be

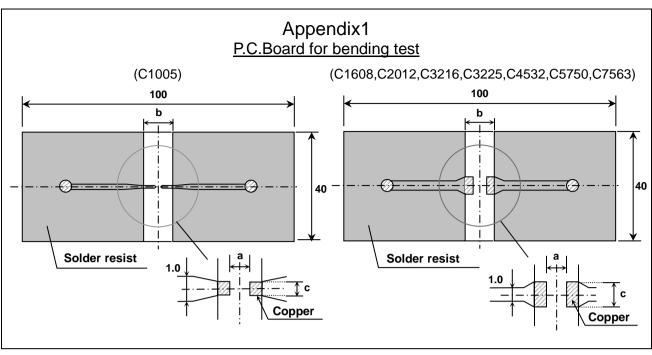
	linueu)		_					
No.		tem	Performance		est or inspection method			
7	Temperat Character	ristics	Capacitance Change (%)	steps sho	nce shall be measured by the wn in the following table after quilibrium is obtained for each			
	(Class2)		Capacitance No voltage applied		step.			
			X5R: ±15	ΔC be calculated ref. STEP3 reading				
			X7R:±15 X7S:±22	Step	Temperature(°C)			
			X7T : +22 - 33	1	Reference temp. ± 2			
			X8R : ± 15	2	Min. operating temp. ± 2			
			X8L : +15 _ 40	3	Reference temp. ± 2			
			:	4	Max. operating temp. ± 2			
				Reference "3. OPERA As for me	n./Max. operating temp and e temp., please refer to ATING TEMPERATURE RANGE" easuring voltage, please contact eales representative.			
8	Robustness of Terminations		No sign of termination coming off, breakage of ceramic, or other abnormal signs.	P.C.Board Apply a p center of direction of Pushing f (2N is app	older the capacitors on a d shown in Appendix 2. ushing force gradually at the a specimen in a horizontal of P.C.board. orce: 5N olied for C1005 type.) me: 10±1s.			
					Capacitor P.C.Board			
9	Bending	External appearance	No mechanical damage.	a P.C.Boa and bend	older the capacitors on and shown in Appendix 1 it for 5mm. (2mm is applied 2 and C5750. 1mm is applied 3.)			
					(Unit : mm)			

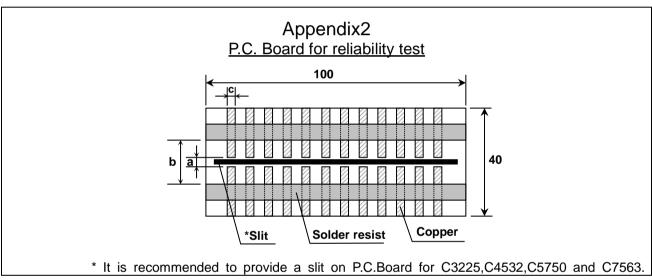
No.		em	Performance			Test c	or inspection method	
10	Solderability	olderability		olderability New solder to cover over 75% of termination. 25% may have pin holes or rough spots but not concentrated in one spot. Ceramic surface of A sections			Solder : Flux :	Sn-3.0Ag-0.5Cu Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.
			shall not l melting	be exp	osed due to ting of termination	Solder temp. :	245±5°C	
			material.			Dwell time :	3±0.3s.	
						Solder position:	Until both terminations are completely soaked.	
					`A section			
11	Resistance to solder heat	External appearance	termination	ons sha	llowed and all be covered at new solder.	Solder :	Sn-3.0Ag-0.5Cu	
	neat	Capacitance		o willi i	lew solder.	Flux :	Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902)	
			Characte	eristics	Change from the value before test	Solder temp. :	25% solid solution.	
			Class1	C0G	± 2.5 %	Colder temp	200±3 C	
			-	X5R X7R X7S		Dwell time :	10±1s.	
			Class2	X7T X8R X8L	±7.5 %	Solder position :	Until both terminations are completely soaked.	
		Q (Class1)	Meet the initial spec.			Pre-heating :	Temp. — 110~140°C Time — 30∼60s.	
		D.F. (Class2)	Meet the	initial s	spec.	Leave the capacitors in ambient condition for Class 1: 6~24h Class 2: 24±2h before measurement.		
		Insulation Resistance	Meet the	initial s	spec.			
		Voltage proof	No insula other dan		eakdown or			
12	Vibration	External appearance	No mech	anical	damage.	Frequency : 10)~55~10Hz sweep time : 1 min.	
		Capacitance	Characte	eristics	Change from the value before test	Amplitude : 1.5	•	
			Class1	COG	± 2.5 %	directions(Tota	• •	
			Class2	X5R X7R X7S X7T X8R X8L	±7.5%		the capacitors on a wn in Appendix 2 before	
		Q (Class1)	Meet the	initial s	spec.			
		D.F. (Class2)	Meet the	initial s	spec.			

No.	lt.	em		Perf	ormance	Test or inspection method												
13	Temperature cycle	External appearance Capacitance	appearance Capacitance Characteristics Change from the			Expose the capacitors in the condition step1 through step 4 listed in the following table. Temp. cycle: 5 cycles												
			Class1	COG														
														X5R	Please contact	Step	Temperature(°C)	Time (min.)
				Class2	X7R X7S X7T	with our sales representative.	1	Min. operating temp.±3	30 ± 3									
				X8R X8L		2	Ambient Temp.	2~5										
		Q	Meet the	initial	spec.	3	Max. operating temp.±2	30 ± 2										
		(Class1)				4	Ambient Temp.	2 ~ 5										
		D.F. (Class2)	Meet the	initial	spec.		Min./Max. operating	•										
		Insulation Resistance	Meet the	initial	spec.	·	e refer to "3. OPERAT PERATURE RANGE"	ΓING										
		Voltage proof	No insula		reakdown or	condit Class Class Reflo	e the capacitors in am tion for 1 : 6~24h 2 : 24±2h before mea w solder the capacitor oard shown in Appen g.	asurement. rs on a										
14	Moisture Resistance	External appearance	No mech	anical	damage.	Test temp.: 40±2°C Test humidity: 90~95%RH												
	(Steady State)	Capacitance	Capacitance	Charact	eristics	Change from the value before test	t Leave	Test time: 500 +24,0h Leave the capacitors in ambient										
			Class1	COG X5R X7R X7S X7T X8R X8L	Please contact with our sales representative.	Leave condit Class	adition for ave the capacitors in ambient adition for ss 1:6~24h ss 2:24±2h before measurement.											
		Q (Class1)	350 min.			Reflow solder the capacitors on a P.C.Board shown in Appendix2 before												
		D.F. (Class2)	200% of initial spec. max.			testing												
		Insulation Resistance	(As for the voltage 1	ne capa 6V DC Ω or 10	MΩ·μF min. acitors of rated C and lower, MΩ·μF min.), ller.													

No.	It	em		Perfo	ormance	Test or inspection method										
15	Moisture Resistance	External appearance	No mech	anical	damage.	Test temp.: 40±2°C Test humidity: 90~95%RH Applied voltage: Rated voltage										
		Capacitance	Charact	eristics	Change from the value before test	Test time: 500 +24,0h Charge/discharge current: 50mA or lower										
			Class1	C0G X5R		Leave the capacitors in ambient condition for										
			X7R X7S	Please contact with our sales representative.	Class 1 : 6~24h Class 2 : 24±2h before measurement.											
				X8R X8L	Toprocomanion	Reflow solder the capacitors on a P.C.Board shown in Appendix2 before										
		Q (Class1)	200 min.			testing. Initial value setting (only for class 2)										
		D.F. (Class2)	200% of i	nitial s	pec. max.	Voltage conditioning 《After voltage treat the capacitors under testing temperature and voltage for 1 hour,》 leave the										
		Insulation Resistance	(As for th voltage 1	e capa 6V DC r 5MΩ	Ω·μF min. acitors of rated and lower, ·μF min.), ler.	capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.										
16	Life	External appearance	No mech	anical	damage.	Test temp. : Maximum operating temperature±2°C										
		Capacitance	Charact	eristics	Change from the	Applied voltage : Please contact with our sales representative.										
			014	C0C	value before test	Test time: 1,000 +48,0h										
														Class1 C0G X5R Pleas	Please contact	Charge/discharge current : 50mA or lowe
													X7R	with our sales	Leave the capacitors in ambient	
								Class2	X7S X7T	representative.	condition for					
				X8R		Class 1 : 6~24h										
				X8L		Class 2 : 24±2h before measurement.										
		Q (Class1)	350 min.			Reflow solder the capacitors on a P.C.Board shown in Appendix2 before testing.										
		D.F. (Class2)	200% of i	nitial s	pec. max.											
		Insulation			MΩ·μF min.	Initial value setting (only for class 2)										
		Resistance	voltage 1	6V DC or 10	acitors of rated and lower, MΩ·μF min.), ler.	Voltage conditioning 《After voltage trea the capacitors under testing temperature and voltage for 1 hour,》 leave the capacitors in ambient condition for 24±2h before measurement.										
	1		1			Use this measurement for initial value.										

^{*}As for the initial measurement of capacitors (Class2) on number 7,11,12,13 and 14 leave capacitors at 150 –10,0°C for 1 hour and measure the value after leaving capacitors for 24±2h in ambient condition.





(Unit : m					
Symbol Case size	а	b	С		
C1005 [CC0402]	0.4	1.5	0.5		
C1608 [CC0603]	1.0	3.0	1.2		
C2012 [CC0805]	1.2	4.0	1.65		
C3216 [CC1206]	2.2	5.0	2.0		
C3225 [CC1210]	2.2	5.0	2.9		
C4532 [CC1812]	3.5	7.0	3.7		
C5750 [CC2220]	4.5	8.0	5.6		
C7563 [CC3025]	5.5	9.1	6.9		

1. Material : Glass Epoxy(As per JIS C6484 GE4)

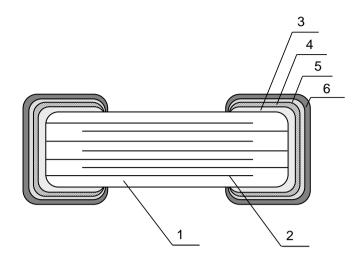
2. Thickness: Appendix 1 — 0.8mm (C1005

— 1.6mm (C1608, C2012, C3216, C3225, C4532, C5750, C7563)

: Appendix 2 — 1.6mm

Copper(Thickness:0.035mm)
Solder resist

8. INSIDE STRUCTURE AND MATERIAL



Na	NAME	MATERIAL			
No.	NAME	Class1	Class2		
1	Dielectric	CaZrO₃	BaTiO₃		
2	Electrode	Nickel (Ni)			
3		Copper (Cu)			
4	Termination	Conductive resin (Filler : Ag)			
5	remination	Nickel (Ni)			
6		Tin (Sn)			

9. CAUTION FOR PRODUCTS WITH SOFT TERMINATION

This product contains Ag (Silver) as part of the middle layer of termination.

To avoid electromigration of Ag under high temperature and humidity, and failures caused by corrosive gas, chip capacitors on P.C boards should be protected by moisture proof-sealing.

10. PACKAGING

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

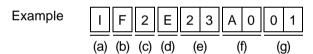
- 10.1 Each plastic bag for bulk packaging contains 1000pcs. And the minimum quantity for Bulk packaging is 1000pcs.
- 10.2 Tape packaging is as per 14. TAPE PACKAGING SPECIFICATION
- .*C1005[CC0402] type is applicable to tape packaging only.
 - 1) Inspection No.*
 - 2) TDK P/N
 - 3) Customer's P/N
 - 4) Quantity

*Composition of Inspection No.

Example
$$\underline{F}$$
 $\underline{2}$ \underline{A} $\underline{23}$ $\underline{001}$ (a) (b) (c) (d) (e)

- (a) Line code
- (b) Last digit of the year
- (c) Month and A for January and B for February and so on. (Skip I)
- (d) Inspection Date of the month.
- e) Serial No. of the day

^{*}Composition of new Inspection No. (Implemented on and after May 1, 2019 in sequence)



- (a) Prefix
- (b) Line code
- (c) Last digit of the year
- (d) Month and A for January and B for February and so on. (Skip I)
- (e) Inspection Date of the month.
- (f) Serial No. of the day(00 ~ ZZ)
- (g) Suffix(00 ~ ZZ)

Until the shift is completed, either current or new composition of inspection No. will be applied.

11. RECOMMENDATION

As for C3225 [CC1210] and larger, It is recommended to provide a slit (about 1mm wide) in the board under the components to improve washing Flux. And please make sure to dry detergent up completely before.

12. SOLDERING CONDITION

As for C1005[CC0402], C3225[CC1210] and larger, reflow soldering only. For other case sizes than the above, reflow soldering is recommended.

^{*}It was shifted to the new inspection No. on and after May 2019, but the implementation timing may be different depending on shipment bases.

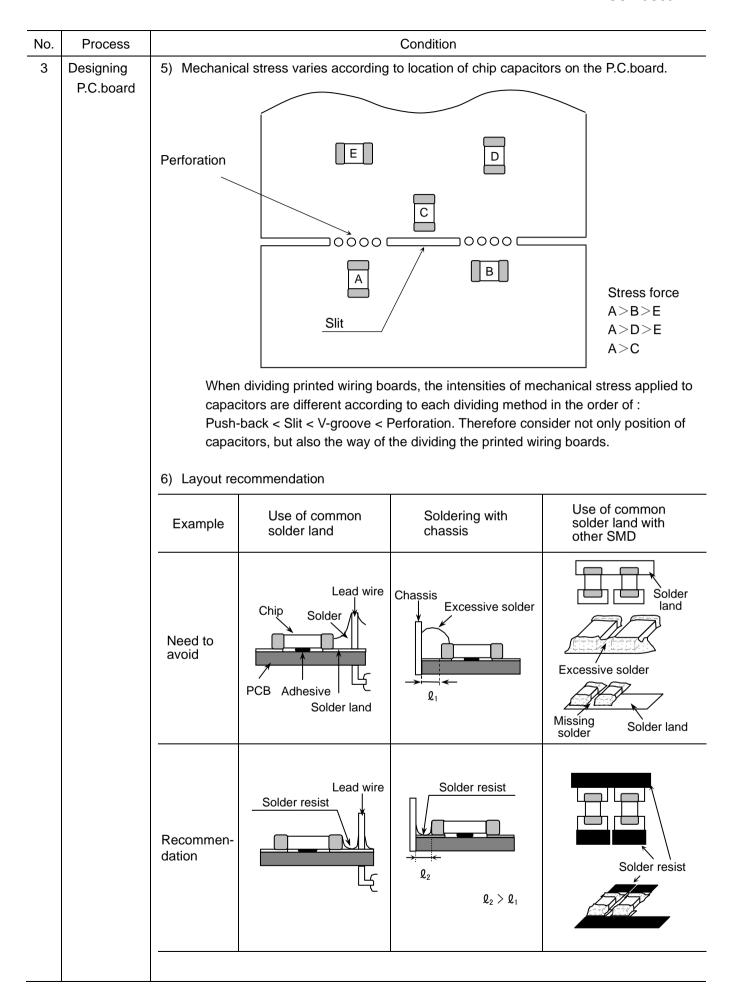
13. CAUTION

No.	Process	Condition
1	Operating	1-1. Storage, Use
	Condition (Storage, Use,	The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. JIS C 60721-3-1 Class 1K2 should be followed for the other climatic conditions.
	Transportation)	1) High temperature and humidity environment may affect a capacitor's solder ability because it accelerates terminal oxidization. They also deteriorate performance of taping and packaging. Therefore, SMD capacitors shall be used within 6 months. For capacitors with terminal electrodes consisting of silver or silver-palladium which tend to become oxidized or sulfurized, use as soon as possible, such as within one month after opening the bag.
		2) When capacitors are stored for a longer time period than 6 months, confirm the solderability of the capacitors prior to use. During storage, keep the minimum packaging unit in its original packaging without opening it. Do not deviate from the above temperature and humidity conditions even for a short term.
		3) Corrosive gasses in the air or atmosphere may result in deterioration of the reliability, such as poor solderability of the terminal electrodes. Do not store capacitors where they will be exposed to corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine ammonia etc.)
		4) Solderability and electrical performance may deteriorate due to photochemical change in the terminal electrode if stored in direct sunlight, or due to condensation from rapid changes in humidity. The capacitors especially which use resin material must be operated and stored in an environment free of dew condensation, as moisture absorption due to condensation may affect the performance.
		5) Refer to JIS C 60721-3-1, class 1K2 for other climate conditions.
		1-2. Handling in transportation In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335C 9.2 Handling in transportation)
2	Circuit design	2-1. Operating temperature
	Caution	Upper category temperature (maximum operating temperature) is specified. It is necessary to select a capacitor whose rated temperature us higher than the operating temperature. Also, it is necessary to consider the temperature distribution in the equipment and seasonal temperature variation.
		2) Surface temperature including self heating should be below maximum operating
		temperature. Due to dielectric loss, capacitors will heat itself when AC is applied due to ESR. Especially at high frequencies, please be careful that the heat might be so extreme.
		Also, even if the surface temperature of the capacitor includes self-heating and is the maximum operating temperature or lower, excessive heating of the capacitor due to self-heating may cause deterioration of the characteristics and reliability of the capacitor.
		The self-heating temperature rise of the capacitor changes depending on the difference in heat radiation due to the mounting method to the device, the ambient temperature, the cooling method of the device and circuit board material and the design, etc.
		The load should be contained so that the self-heating temperature rise of the capacitor body in a natural convection environment at an ambient temperature of 25°C remain below 20°C.
		When using in a high-frequency circuit or a circuit in which a capacitor generates heat, such as when a high-frequency ripple current flows, pay attention to the above precautions. (Note that accurate measurement may not be possible with self-heating measurement when the equipment applies cooling other than natural convection such as a cooling fan.)
		The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration.

No.	Process	Condition
2	Circuit design Caution	 2-2. When overvoltage is applied Applying overvoltage to a capacitor may cause dielectric breakdown and result in a short circuit. The duration until dielectric breakdown depends on the applied voltage and the ambient temperature. 2-3. Operating voltage 1) Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V_{0-P} must be below the rated voltage. — (1) and (2) AC or pulse with overshooting, V_{P-P} must be below the rated voltage. — (3), (4) and (5) When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage.
		Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage
		Positional Measurement (Rated voltage) Vo-P 0
		Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)
		Positional Measurement (Rated voltage)
		Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced.
		The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration.
		4) Abnormal voltage (surge voltage, static electricity, pulse voltage, etc.) shall not exceed the rated voltage.
		5) When capacitors are used in a series connection, it is necessary to add a balancing circuit such as voltage dividing resistors in order to avoid an imbalance in the voltage applied to each capacitor.
		2-4. Frequency When the capacitors (Class 2) are used in AC and/or pulse voltages, the capacitors may vibrate themselves and generate audible sound.

No.	Process			Condition				
3	Designing P.C.board	The amount of solo capacitors.	ler at the termina	tions has a direc	ct effect on the re	liability of the		
		 The greater the amount of solder, the higher the stress on the chip capacitors, and the more likely that it will break. When designing a P.C.board, determine the shape and size of the solder lands to have proper amount of solder on the terminations. 						
		Avoid using cor solder land for	mmon solder lan each termination		minations and pro	ovide individual		
		3) Size and recom	nmended land di	mensions.				
			Chi	ip capacitors Sc	older land			
		Solder resist						
		Reflow soldering				(Unit : mm)		
		Case size	C1005	C1608	C2012	C3216		
		Symbol	[CC0402]	[CC0603]	[CC0805]	[CC1206]		
		A	0.3 ~ 0.5	0.6 ~ 0.8	0.9 ~ 1.2	2.0 ~ 2.4		
		В	0.35 ~ 0.45	0.6 ~ 0.8	0.7 ~ 0.9	1.0 ~ 1.2		
		C	0.4 ~ 0.6	0.6 ~ 0.8	0.9 ~ 1.2	1.1 ~ 1.6		
		Case size	C3225 [CC1210]	C4532 [CC1812]	C5750 [CC2220]	C7563 [CC3025]		
		А	2.0 ~ 2.4	3.1 ~ 3.7	4.1 ~ 4.8	5.2 ~ 5.8		
		В	1.0 ~ 1.2	1.2 ~ 1.4	1.2 ~ 1.4	1.7 ~ 1.9		
		С	1.9 ~ 2.5	2.4 ~ 3.2	4.0 ~ 5.0	6.4 ~ 7.4		
		Flow soldering (l	Inrecommend)		(Unit : mm)			
		Case size Symbol	C1608 [CC0603]	C2012 [CC0805]	C3216 [CC1206]			
		A	0.7 ~ 1.0	1.0 ~ 1.3	2.1 ~ 2.5	-		
		В	0.8 ~ 1.0	1.0 ~ 1.2	1.1 ~ 1.3			
		С	0.6 ~ 0.8	0.8 ~ 1.1	1.0 ~ 1.3	-		
					1	<u>. </u>		

No.	Process			Condition			
3	Designing P.C.board	4)	4) Recommended chip capacitors layout is as following.				
				Disadvantage against bending stress	Advantage against bending stress		
			Mounting face	Perforation or slit	Perforation or slit		
			Break P.C.board with mounted side up.	Break P.C.board with mounted side down.			
				Mount perpendicularly to perforation or slit	Mount in parallel with perforation or slit		
			Chip arrangement (Direction)	Perforation or slit	Perforation or slit		
			Distance from slit	Closer to slit is higher stress $ \begin{pmatrix} \varrho_1 & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ \end{pmatrix} $	Away from slit is less stress		



4	Mounting	4-1. Stress from mo				
		 4-1. Stress from mounting head If the mounting head is adjusted too low, it may induce excessive stress in the chip capacitors to result in cracking. Please take following precautions. 1) Adjust the bottom dead center of the mounting head to reach on the P.C.board surface and not press it. 2) Adjust the mounting head pressure to be 1 to 3N of static weight. 3) To minimize the impact energy from mounting head, it is important to provide support from the bottom side of the P.C.board. See following examples. 				
			Not i	recommended	Recommended	
		Single-sided mounting		Crack	Support pin is not to be underneath the capacitor.	
		Double-sides mounting	Solde		Support pin	
		capacitors to caus jaw and provide s	se crack. Ple ufficient pre	ease control the close	echanical impact on the e up dimension of the centering and replacement of it.	
		4-2. Amount of adhe	esive	→ a → a → a → b → b → b → b → b → b → b	b	
		=		c c		
		_	Example : (C2012 [CC0805], C3	216 [CC1206]	
		_	а	0.2mm m	in.	
		_	b	70 ~ 100բ		
		-	С	Do not touch the s	solder land	

No.	Process		Condition			
5	Soldering	 5-1. Flux selection Flux can seriously affect the performance of capacitors. Confirm the folloselect the appropriate flux. 1) It is recommended to use a mildly activated rosin flux (less than 0.1wt% cl Strong flux is not recommended. 				
		2) Excessive flux must be av	oided. Please provide	proper amount of flux.		
		3) When water-soluble flux is	s used, enough washi	ng is necessary.		
		5-2. Recommended soldering Refer to the following temperature.	- T			
		F	Reflow soldering			
		Reflow soldering is recomm reflow soldering is allowed f	Peak Temp time ended for C1608,C20 or other case sizes. peak temp and peak	12,C3216 types, but only	-	
		Temp./Duration	Reflow so	ldering		
		Solder	Peak temp(°C)	Duration(sec.)		
		Lead Free Solder	260 max.	10 max.		
				1		

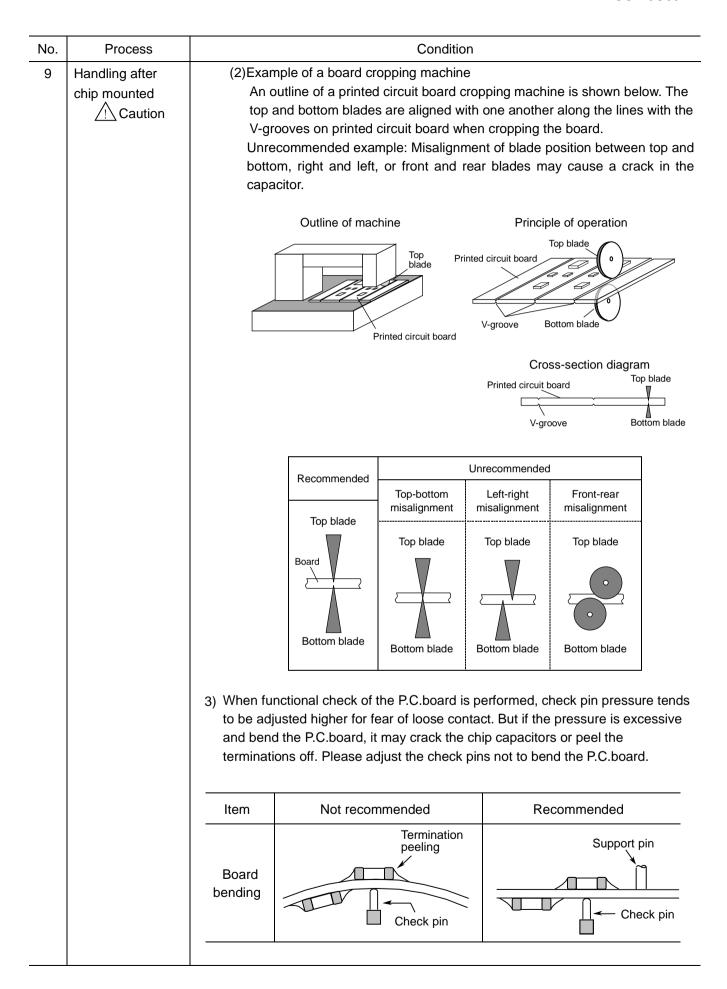
No.	Process		Cond	lition			
5	Soldering	5-4. Soldering profile : Flow					
J	Soldering	Refer to the following tem	•	•	dering.		
			Flow solder	ring			
		1	Preheating Solderi	ing Natural coo	ling		
				*			
		Peak Temp (O _o) · dwap	ver 60 sec. Peak Temp	Over 60 s	ec.		
		Reflow soldering is recom	mended for C10	ded for C1608,C2012,C3216 types.			
		5-5. Recommended soldering peak temp and peak temp duration for Flow soldering Pb free solder is recommended, but if Sn-37Pb must be used, refer to below.					
		Temp./Dura	Temp./Duration Flow soldering				
		Solder	Peak te	Peak temp(°C) Duration		n(sec.)	
		Lead Free Solo	der 260	max.	5 m	ax.	
		Sn-Pb Solder	250	max.	3 m	ax.	
		Recommended solder of Lead Free Solder: Sn-5-6. Avoiding thermal shock	3.0Ag-0.5Cu				
		1) Preheating condition					
		Soldering	Case size			Temp. (°C)	
		Reflow soldering	C1005[CC0402] C2012[CC0805]	, C3216[CC1	206]	ΔT ≦ 150	
			C3225[CC1210] C5750[CC2220]	-	-	$\Delta T \leq 130$	
		Flow soldering	C1608[CC0603] C3216[CC1206]	, C2012[CC0		ΔT ≦ 150	
		Cooling condition Natural cooling using ai cleaning, the temperatu					

No.	Process	Condition				
5	Soldering	5-7. Amount of solder Excessive solder will induce higher tensile force in chip capacitors when temperature changes and it may result in chip cracking. In sufficient solder may detach the capacitors from the P.C.board.				
		Excessive solder Higher tensile force in chip capacitors to cause crack				
		Adequate Maximum amount Minimum amount				
		Insufficient solder Low robustness may cause contact failure or chip capacitors come off the P.C.board.				
	 5-8. Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder. 5-9. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335C Annex A (Informative) Recommendations to prevent the tombstone phenomenon) 					

No.	Process		Condition				
6	Solder repairing	Solder repairing is unavoidable, refer to below. 6-1. Solder repair by solder iron 1) Selection of the soldering iron tip Tip temperature of solder iron varies by its type, P.C.board material and solder land size. The higher the tip temperature, the quicker the operation. However, heat shock may cause a crack in the chip capacitors. Please make sure the tip temp. before soldering and keep the peak temp and time in accordance with following recommended condition. Manual soldering (Solder iron)					eration. ors.
		Recommended solder iron condition (Sn-Pb Solder and Lead Free Solder)					
		Case size	Tem	p. (°C)	Duration (sec.)	Wattage (\	N) Shape (mm)
	C1005[CC0402] C1608[CC0603] C2012[CC0805] C3216[CC1206] C3225[CC1210] C4532[CC1812] C5750[CC2220] 280 max.		3 max.	20 max.	ø3.0 max.		
		C7563[CC3025] * Please preheat t	he chi	p capaci	tors with the cond	lition in 6-2 t	to avoid the
		 thermal shock. 2) Direct contact of the soldering iron with ceramic dielectric of chip capacitor cause crack. Do not touch the ceramic dielectric and the terminations by siron. 3) It is not recommended to reuse dismounted capacitors. 6-2. Avoiding thermal shock 					
		ŭ					
		Preh <u>eating condit</u> Soldering			Case size		Temp. (°C)
					CC0402], C1608[C0 CC0805], C3216[C0		$\Delta T \leq 150$
		Manual solde	ering		CC1210], C4532[C0 CC2220], C7563[C0		ΔT ≦ 130
				-			

No.	Process	Condition
7	Cleaning	1) If an unsuitable cleaning fluid is used, flux residue or some foreign articles may
		stick to chip capacitors surface to deteriorate especially the insulation resistance.
		2) If cleaning condition is not suitable, it may damage the chip capacitors.
		2)-1. Insufficient washing
		(1) Terminal electrodes may corrode by Halogen in the flux.
		(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.
		(3) Water soluble flux has higher tendency to have above mentioned problems (1) and (2).
		2)-2. Excessive washing
		When ultrasonic cleaning is used, excessively high ultrasonic energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, following is the recommended condition.
		Power : 20 W/lmax.
		Frequency : 40 kHz max.
		Washing time : 5 minutes max.
		2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may
		bring the same result as insufficient cleaning.

	T	
No.	Process	Condition
8	Coating and molding of the P.C.board	 This product contains Ag (Silver) as part of the middle layer of termination. To avoid electromigration of Ag under high temperature and humidity, and failures caused by corrosive gas, chip capacitors on P.C boards should be protected by moisture proof-sealing. When the P.C.board is coated, please verify the quality influence on the product.
		3) Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors.4) Please verify the curing temperature.
		Thease verify the curing temperature.
9	Handling after chip mounted	Please pay attention not to bend or distort the P.C.board after soldering in handling otherwise the chip capacitors may crack.
	<u> </u>	Bend Twist
		 Printed circuit board cropping should not be carried out by hand, but by using the proper tooling. Printed circuit board cropping should be carried out using a board cropping jig as shown in the following figure or a board cropping apparatus to prevent inducing mechanical stress on the board. (1)Example of a board cropping jig Recommended example: The board should be pushed from the back side, close to the cropping jig so that the board is not bent and the stress applied to the capacitor is compressive. Unrecommended example: If the pushing point is far from the cropping jig and the pushing direction is from the front side of the board, large tensile stress is applied to the capacitor, which may cause cracks.
		Outline of jig Recommended Unrecommended
		Printed circuit board Board cropping jig V-groove Slot Direction of load Load point Load point Components V-groove Slot Slot



No.	Process	Condition
10	Handling of loose chip capacitors	If dropped the chip capacitors may crack. Once dropped do not use it. Especially, the large case sized chip capacitors are tendency to have cracks easily, so please handle with care. Crack Floor
		Piling the P.C.board after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitors of another board to cause crack. P.C.board Crack
11	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
12	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335C Annex F (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient: 3 multiplication rule, Temperature acceleration coefficient: 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.

No.	Process	Condition
13	Caution during operation of equipment	 A capacitor shall not be touched directly with bare hands during operation in order to avoid electric shock. Electric energy held by the capacitor may be discharged through the human body when touched with a bare hand. Even when the equipment is off, a capacitor may stay charged. The capacitor should be handled after being completely discharged using a resistor. The terminals of a capacitor shall not be short-circuited by any accidental contact with a capacitative chief.
		with a conductive object. A capacitor shall not be exposed to a conductive liquid such as an acid or alkali solution. A conductive object or liquid, such as acid and alkali, between the terminals may lead to the breakdown of a capacitor due to short circuit
		3) Confirm that the environment to which the equipment will be exposed during transportation and operation meets the specified conditions. Do not to use the equipment in the following environments. (1) Environment where a capacitor is spattered with water or oil (2) Environment where a capacitor is exposed to direct sunlight (3) Environment where a capacitor is exposed to Ozone, ultraviolet rays or radiation (4) Environment where a capacitor exposed to corresive gas (e.g. bydrogen).
		 (4) Environment where a capacitor exposed to corrosive gas(e.g. hydrogen sulfide, sulfur dioxide, chlorine. ammonia gas etc.) (5) Environment where a capacitor exposed to vibration or mechanical shock exceeding the specified limits. (6) Atmosphere change with causes condensation
14	Others Caution	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) and automotive application under a normal operation and use condition.
		The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.
		 (1) Aerospace/Aviation equipment (2) Transportation equipment (electric trains, ships, etc. except automotive application) (3) Medical equipment (Excepting Pharmaceutical Affairs Law classification Class1, 2) (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment
		 (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment (12) Safety equipment (13) Other applications that are not considered general-purpose applications
		When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment.

14. TAPE PACKAGING SPECIFICATION

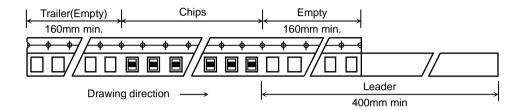
1. CONSTRUCTION AND DIMENSION OF TAPING

1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3, 4.

Dimensions of plastic tape shall be according to Appendix 5, 6.

1-2. Bulk part and leader of taping

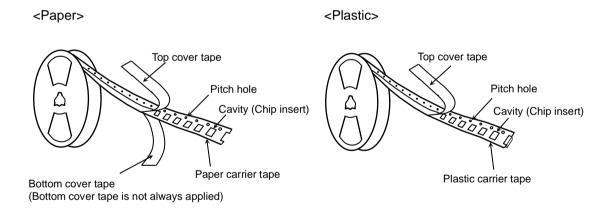


1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 7, 8.

Dimensions of Ø330 reel shall be according to Appendix 9, 10.

1-4. Structure of taping

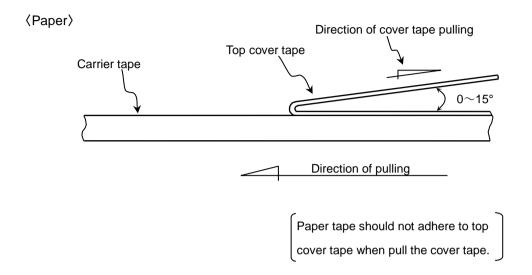


2. CHIP QUANTITY

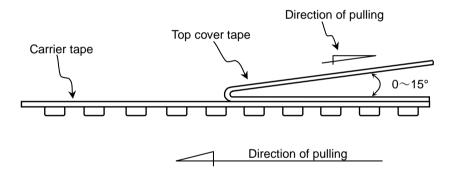
Please refer to detail page on TDK web.

3. PERFORMANCE SPECIFICATIONS

3-1. Fixing peeling strength (top tape)0.05N < Peeling strength < 0.7N

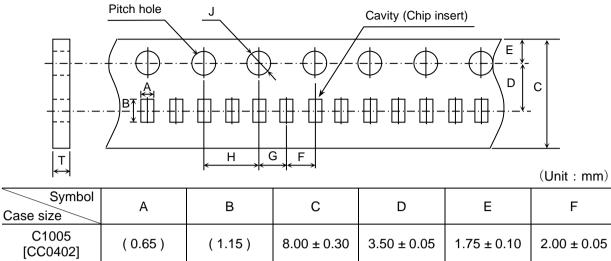


⟨Plastic⟩



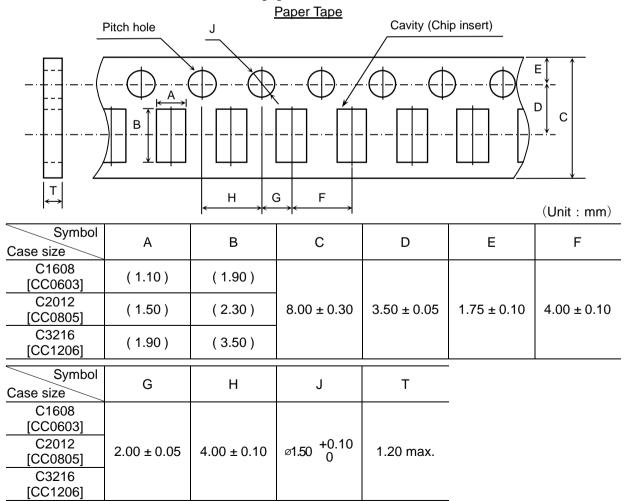
- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. When removing the cover tape, there shall not be difficulties by unfitting clearance gap, burrs and crushes of cavities. Also the sprocket holes shall not be covered by absorbing dust into the suction nozzle.

Paper Tape



[CC0402]	(0.65)	(1.15)	8.00 ± 0.30	3.50 ± 0.05	
Symbol Case size	G	Н	J	Т	٠
C1005 [CC0402]	2.00 ± 0.05	4.00 ± 0.10	ø1.50 ^{+0.10}	0.75 max.	

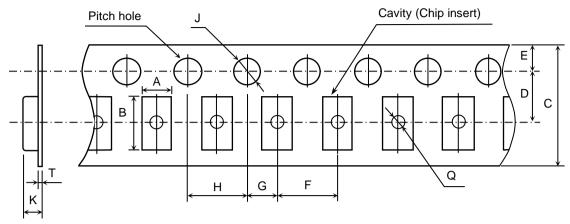
Appendix 4



) Reference value.

^() Reference value. * Applied to thickness, 0.50 +0.20,-0.10mm products.

Plastic Tape



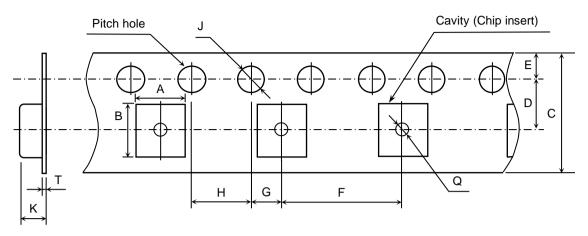
(Unit : mm)

						(
Symbol Case size	Α	В	С	D	E	F
C2012 [CC0805]	(1.50)	(2.30)	8.00 ± 0.30	3.50 ± 0.05		
C3216 [CC1206]	(1.90)	(3.50)	0.00 ± 0.50	3.30 ± 0.03	1.75 ± 0.10	4.00 ± 0.10
C3225 [CC1210]	(2.90)	(3.60)	8.00 ± 0.30 or 12.00 ± 0.30	3.50 ± 0.05 or 5.50 ± 0.05		
Symbol Type	G	Н	J	К	Т	Q
C2012 [CC0805]				2.50 max.		
C3216 [CC1206]	2.00 ± 0.05	4.00 ± 0.10	Ø1.50 +0.10	2.50 max.	0.60 max.	Ø0.50 min.
C3225 [CC1210]				3.40 max.		

^() Reference value.

Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.

Plastic Tape



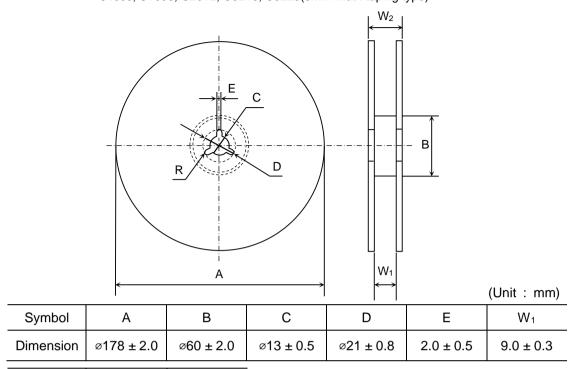
(Unit:mm)

						` ,
Symbol Case size	А	В	С	D	E	F
C4532 [CC1812]	(3.60)	(4.90)	12.00 ± 0.30	5.50 ± 0.05		8.00 ± 0.10
C5750 [CC2220]	(5.40)	(6.10)	12.00 ± 0.30	5.50 ± 0.05	1.75 ± 0.10	6.00 ± 0.10
C7563 [CC3025]	(6.90)	(8.00)	16.00 ± 0.30	7.50 ± 0.05		12.00 ± 0.10
Symbol Case size	G	Н	J	K	Т	Q
C4532 [CC1812]	2.00 . 0.05			6 F0 may		at E0 min
C5750 [CC2220]	2.00 ± 0.05	4.00 ± 0.10	Ø1.50 +0.10	6.50 max.	0.60 max.	ø1.50 min.
		1			1	

⁾ Reference value.

Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.

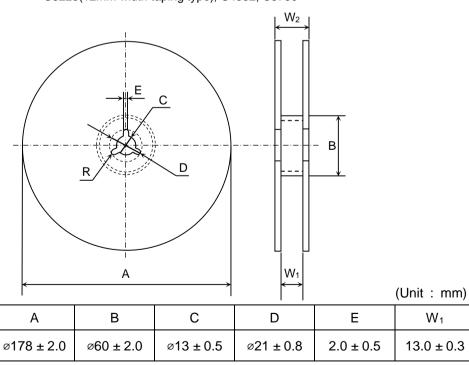
<u>Dimensions of reel</u> (Material : Polystyrene) C1005, C1608, C2012, C3216, C3225(8mm width taping type)



Symbol W_2 RDimension 13.0 ± 1.4 1.0

Appendix 8

<u>Dimensions of reel</u> (Material : Polystyrene) C3225(12mm width taping type), C4532, C5750



Symbol	W_2	R
Dimension	17.0 ± 1.4	1.0

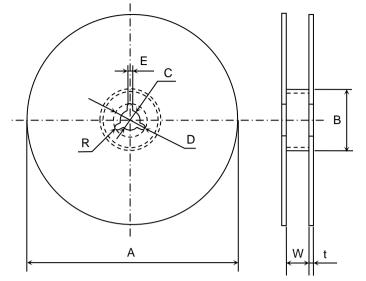
Symbol

Dimension

(Unit: mm)

Appendix 9

<u>Dimensions of reel</u> (Material : Polystyrene) C1005, C1608, C2012, C3216, C3225(8mm width taping type)

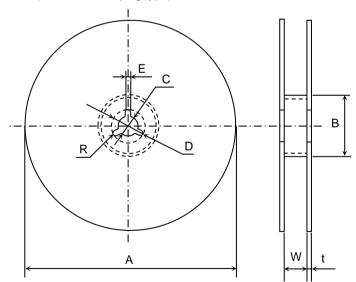


Symbol	А	В	С	D	Е	W
Dimension	ø382 max. (Nominal ø330)	ø50 min.	Ø13 ± 0.5	ø21 ± 0.8	2.0 ± 0.5	10.0 ± 1.5

Symbol	t	R		
Dimension	2.0 ± 0.5	1.0		

Appendix 10

<u>Dimensions of reel</u> (Material : Polystyrene) C3225(12mm width taping type), C4532, C5750, C7563



(Unit: mm)

Symbol	Α	В	С	D	Е	W
Dimension	Ø382 max. (Nominal Ø330)	ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	14.0 ± 1.5 *17.5 ± 1.5

Symbol	t	R		
Dimension	2.0 ± 0.5	1.0		

^{*} Applied to C7563.